

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER OF PATENTS AND TRADEMARKS Washington, D.C. 20231 www.uspto.gov

APPLICATION NO.	FII	ING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/629,204	07/31/2000		Kamran Uz Zaman	690-009312-US(PAR)D/99836 5766	
7	590	02/12/2003			
Kevin P Correll Perman & Green LLP 425 Post Road				EXAMINER KAO, CHIH CHENG G	
Fairfield, CT 06430			ART UNIT	PAPER NUMBER	
				2882	
				DATE MAILED: 02/12/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

			M. A. William M. A.				
		Application No.	Applicant(s)				
		09/629,204	ZAMAN ET AL.				
. 0	ffice Action Summary	Examiner	Art Unit				
		Chih-Cheng Glen Kao	2882				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. - If NO period for reply is specified above, the maximum studyory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status							
	ponsive to communication(s) filed on <u>08</u>	November 2002 .					
	· · · · · · · · · · · · · · · · · · ·	nis action is non-final.	•				
3)	ee this application is in condition for allow	ance except for formal matters, p					
closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. Disposition of Claims							
4)⊠ Claim	n(s) <u>1-23</u> is/are pending in the application	n.					
4a) O	f the above claim(s) is/are withdra	wn from consideration.	·				
5)∏ Claim	n(s) is/are allowed.						
6)⊠ Claim	n(s) <u>1-23</u> is/are rejected.						
7) Claim	n(s) is/are objected to.						
8)∐ Claim	n(s) are subject to restriction and/o	or election requirement.					
Application Papers							
9) The specification is objected to by the Examiner.							
10) ☐ The drawing(s) filed on is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
	roposed drawing correction filed on <u>08 No</u>		b) disapproved by the Examiner.				
If approved, corrected drawings are required in reply to this Office action.							
12) The oath or declaration is objected to by the Examiner.							
Priority under 35 U.S.C. §§ 119 and 120							
	13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).						
a) All b) Some * c) None of:							
_	1. Certified copies of the priority documents have been received.						
2. Certified copies of the priority documents have been received in Application No							
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 							
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).							
a) ☐ The translation of the foreign language provisional application has been received. 15)☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.							
Attachment(s)							
2) Notice of Dra	ferences Cited (PTO-892) uftsperson's Patent Drawing Review (PTO-948) Disclosure Statement(s) (PTO-1449) Paper No(s) _	5) Notice of Informal	y (PTO-413) Paper No(s) Patent Application (PTO-152)				

, Art Unit: 2882

DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 1. Claims 1, 6, 8, 9, 11, 18-21, and 23 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hennessey et al. (US Patent 6487307) in view of DeYong et al. (WO 99/16010), Herbert et al. (US Patent 5,352,329), and Kanno et al. (US Patent 6069971).

Hennessey et al. discloses a system and method for inspecting manufactured objects comprising an illumination source with an optical sensor to obtain gray level picture data (col. 2, lines 60-67).

However, Hennessey et al. does not disclose a controller determining the ratio of distinguishable pixels to the total number of pixels with a threshold detector or discrimator to sense bottom edge wipe defects on an OPC device, a data storage area to store threshold values and classification result of acceptable, non-acceptable, or quasi-acceptable, and a monitoring device with a visual display.

DeYong et al. teaches inspecting objects for defects with an optical system or method (Page 1, lines 4-10). Herbert et al. teaches inspecting OPC devices for bottom edge wipe defects (col. 1 to col. 2, line 11). Kanno et al. teaches a controller determining the ratio of distinguishable pixels to the total number of pixels (col. 8, line 50, to col. 9, line 2) with a

· Art Unit: 2882

threshold detector or discriminator (col. 9, lines 3-23), a data storage area (Fig. 6) to store threshold values (col. 8, lines 50-60) and classification result classification result of acceptable, non-acceptable, or quasi-acceptable (Fig. 8, "ST109", "ST110", and "ST111"), and a monitoring device with a visual display (Fig. 5, #2, and col. 7, lines 59-61).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to inspect objects for defects with an optical system of method as taught by DeYong et al. with the system and method of Hennessey et al., since one would be motivated to have automated inspection of manufactured products to fill a need for inherent inefficiency of human inspectors caused, in part, by an inability to maintain a continuous force and to apply a consistent analysis from day to day as implied from DeYong et al. (Page 1, lines 10-15).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to inspect OPC devices for bottom edge wipe defects as taught by Herbert et al. with the system and method of Hennessey et al., since one would be motivated to make sure that the bottom edge wipe methods are successful and reduce defects that may cause problems such as interference with charging devices or developer housing as implied from Herbert et al. (col. 1, lines 30-40, and col. 2, lines 1-11).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have the ratio, threshold detector, data storage area, and monitoring device of Kanno et al. with the system and method of Hennessey et al., since one would be motivated to use these components to ensure that a product is within tolerable levels of quality as implied from Kanno et al. (col. 9, lines 3-23).

· Art Unit: 2882

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have the classification result of acceptable, non-acceptable, or quasi-acceptable of Kanno et al. with the system and method of Hennessey et al., since one would be motivated to use have these levels to improve work efficiency as implied from Kanno et al. (col. 9, lines 3-23) by having the designer further look at quasi-acceptable objects only rather than all objects that are not acceptable.

2. Claims 2-5, 12, and 22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. as applied to claims 1, 11, and 20 above, and further in view of Roy et al. (US patent 6118540).

Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. suggests a system and method as recited above.

However, Hennessey et al. does not disclose a light emitting diode (LED), laser, emitter or CCD camera.

Roy et al. teaches an LED (col. 2, line 53), laser (col. 2, lines 60-64), emitter (col. 2, lines 60-64) or CCD camera (col. 2, lines 38).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have the LED, laser, emitter, or CCD of Roy et al. with the suggested method and device of Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al., since an LED, laser, emitter, or CCD are considered conventional in the art for inspection systems and methods as implied from Roy et al. One would be motivated to use these components to perform computer vision analysis as shown by Roy et al. (col. 2, lines 46-49).

• Art Unit: 2882

3. Claim 7 is rejected under 35 U.S.C. 103(a) as being unpatentable over Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. as applied to claim 1 above, and further in view of Juvinall (US Patent 4066363) and Maeda et al. (US Patent 5153444).

Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. suggests a system as recited above.

However, Hennessey et al. does not disclose a threshold detector comprising an array of pixels or a pixel counter.

Juvinall teaches a threshold detector comprising an array or pixels (col. 8, lines 22-25, and Fig. 1, #41). Maeda et al. teaches a pixel counter (col. 10, lines 5-35).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have the threshold detector array of Juvinall with the suggested device of Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al., since one would be motivated to use an array to process data from different pixels as implied from Juvinall (col. 8, lines 22-25) for parallel processing which is faster then serial processing.

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have the pixel counter of Maeda et al. with the suggested device of Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al., since one would be motivated to use the counter to count the number of defective pixels to see if it reaches a preset value and indicates a defect as implied from Maeda et al. (col. 10, lines 27-50).

- Art Unit: 2882

4. Claim 10 is rejected under 35 U.S.C. 103(a) as being unpatentable over Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. as applied to claim 8 above, and further in view of Langley (US Patent Application Publication 2001/0012392).

Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. suggests a system as recited above.

However, Hennessey et al. does not disclose an audio monitor.

Langley teaches an audio monitor (Page 2, Paragraph 24).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have the audio monitor of Langley with the suggested method and device of Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al., since one would be motivated to use it to warn the user of defects as implied from Langley (Page 2, Paragraph 24).

5. Claims 13 and 14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. as applied to claim 11, and further in view of Lemmers et al. (US Patent 4641966).

Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. suggests a method as recited above.

However, Hennessey et al. does not disclose analog or digital signals.

Lemmers et al. implies analog (which is inherent before processing an electrical signal into a digital signal) and digital signals (col. 2, lines 30-35).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have analog or digital signals of Lemmers et al. with the suggested

- Art Unit: 2882

method of Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al., since analog and digital signal processing is well known in the art as equivalent processing means for its use in the art of inspection devices. The selection of any of known equivalent to process signals would be within the level of ordinary skill in the art. Lastly, the applicant has not disclosed that analog or digital signals solves any stated problem and it appears that the invention would perform equally well either processing means. One would be motivated to use analog signals to have a real-time accuracy in signal detection. One would be motivated to use digital signals for more advanced processing applications.

6. Claim 15 and 16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. as applied to claim 11 above, and further in view of Maeda et al.

For purposes of being concise, Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. suggests a method as recited above.

However, Hennessey et al. does not disclose comparing with a gray pixel count.

Maeda et al. teaches comparing with a gray (Abstract, line 2) pixel count (col. 11, lines 34-37).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to have the pixel count of Maeda et al. with the suggested method of Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al., since one would be motivated to use the count to determine defects as implied from Maeda et al. (col. 11, lines 34-41).

- Art Unit: 2882

7. Claim 17 is rejected under 35 U.S.C. 103(a) as being unpatentable over Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. as applied to claim 11 above, and further in view of Juvinall.

Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al. suggests a system as recited above.

However, Hennessey et al. does not disclose comparing with a predetermined analog voltage level.

Juvinall teaches comparing with a predetermined analog voltage level (Fig. 5, #42, and col. 8, lines 55-69).

It would have been obvious, to one having ordinary skill in the art at the time the invention was made, to compare with an analog voltage signal as taught by Juvinall with the suggested method of Hennessey et al. in view of DeYong et al., Herbert et al., and Kanno et al., since one would be motivated to use analog signals to control the levels of reference signals as implied from Juvinall (col. 8, lines 56-68), which may be done with a potentiometer.

Allowable Subject Matter

8. The indicated allowability of claims 16 and 23 are withdrawn in view of the newly discovered reference(s) to Hennessey et al., DeYong et al., and Kanno et al. Rejections based on the newly cited reference(s) are as recited above.

· Art Unit: 2882

Response to Arguments

- 9. The objection to the drawings in the rejection mailed 8/12/02 have been withdrawn in light of the proposed drawings filed 11/8/02.
- 10. Applicant's arguments filed 4/10/02 have been fully considered but they are not persuasive.

Regarding Herbert et al., Herbert et al. still discusses the detection of bottom edge wipe manufacturing defects in OPC devices.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Chih-Cheng Glen Kao whose telephone number is (703) 605-5298. The examiner can normally be reached on M - Th (8 am to 5 pm).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Robert Kim can be reached on (703) 305-3492. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 308-7722 for regular communications and (703) 308-7724 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

gk February 10, 2003 SUTTO THE COLUMN COLUMN